

<b>FORM PTO-1449</b> US Department of 61730 U.S. PTO Commerce Patent and Trademark Office  02/20/97	ATTY DOCKET NO. P41 90273	SERIAL NO. 08/704,467
	<b>APPLICANT</b> Gallagher et al.	
	<b>FILING DATE</b> 08/28/96	<b>GROUP</b> 1511

#### U.S. PATENT DOCUMENTS 4

EXAM. INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
MK		5,376,403	12/27/94	Capote et al.	427	96	10/1/91
MK		5,463,190	10/31/95	Carson et al.	174	259	4/4/94

#### FOREIGN PATENT DOCUMENTS

EXAM. INITIALS		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION (YES/NO)
		NONE					

#### OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages)

MK	/	Gallagher et al., ABSTRACT "Transient Liquid Phase Sintering Conductive Adhesives" 568-573 (1995)
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RECEIVED  
MAR 6 1997  
GROUP 1500

AND NO OTHERS

EXAMINER <i>Mah K</i>	DATE CONSIDERED 10/1/97
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LIST OF PATENTS AND PUBLICATIONS FOR  
APPLICANT'S INFORMATION DISCLOSURE  
STATEMENT

(USE SEVERAL SHEETS IF NECESSARY)

APPLICANT  
Capote et al.FILING DATE  
10/17/94GROUP  
Unknown

REFERENCE DESIGNATION		U.S. PATENT DOCUMENTS			
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	FILING DATE SUBCLASS IF APPROPRIATE
<i>MK</i>	AA 2,993,815	7/25/61	TREPTOW	117	212
↑	AB 3,256,109	6/14/66	BERGER	117	38
	AC 3,410,714	11/12/68	JONES	117	46
	AD 3,679,439	7/25/72	MILGRAM	262	514
	AE 3,681,135	8/1/72	GRAHAM	106	1
	AF 3,714,709	2/6/73	LIEDERBACH	29	626
	AG 3,791,027	2/12/74	ANGELO et al.	148	23
	AH 3,800,020	3/26/74	PARFET	264	104
	AI 3,801,364	4/2/74	KOJINA et al.	117	212
↓	AJ 3,808,046	4/30/74	DAVEY	262	512
<i>MK</i>	AK 3,857,798	12/31/74	WALL et al.	262	514

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	NO
<i>MK</i>	AL 134,737	3/24/60	USSR	—	—	X	
↑	AM 237,840	7/30/86	GERMANY	—	—	X	
	AN 239,901	32387	EPO	—	—		
↓	AO 261,868	11/9/88	GERMANY	—	—		X
<i>MK</i>	AP 1,190,736	7/23/85	CANADA	—	—		

## OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

*MK* AR Feeley, Berbst & Schmeckenbecher, Conductive Pasts, IBM Technical Disclosure Bulletin, 12/68*MK* AS "Electricity-Carrying Ink Used in Circuit Boards" Wall Street Journal (9/28/88)*MK* AT "Prototype Tool Turns Out Multilevel Circuit Boards" Electronic Design (5/25/89)EXAMINER *Mak* DATE CONSIDERED 10/1/97

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## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS IF APPROPRIATE	FILING DATE
<i>MK</i>	AA <sup>2</sup> 3,904,555	9/9/75	MATSUDA et al.	252	514	
↑	AB <sup>2</sup> 3,960,777	6/1/76	COYLE	252	514	
	AC <sup>2</sup> 3,983,075	9/28/76	MARSHALL et al.	252	511	
	AD <sup>2</sup> 4,000,016	12/28/76	LAZZARINI et al.	148	23	
	AE <sup>2</sup> 4,001,146	1/4/77	HOROWITZ	252	514	
	AF <sup>2</sup> 4,127,699	11/28/78	AUMILLER et al.	428	461	
	AG <sup>2</sup> 4,147,669	4/3/79	SHAHEEN et al.	252	512	
	AH <sup>2</sup> 4,186,036	1/29/80	ELMS et al.	427	386	
	AI <sup>2</sup> 4,233,103	11/11/80	SHAHEEN	156	331	
↓	AJ <sup>2</sup> 4,273,593	6/16/81	MASTRANGELO	148	24	
<i>MK</i>	AK <sup>2</sup> 4,278,702	7/14/81	JENQ	427	96	

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<i>MK</i>	AL <sup>2</sup> 1,455,513	2/12/74	GREAT BRITAIN			
<i>MK</i>	AM <sup>2</sup> 2,054,277	6/27/80	GREAT BRITAIN			
<i>MK</i>	AN <sup>2</sup> 49-97,846	8/17/74	JAPAN			X
<i>MK</i>	AO <sup>2</sup> 50-100,596	8/9/75	JAPAN			X
<i>MK</i>	AP <sup>2</sup> 53-33,389	3/29/78	JAPAN			X

## OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

AR<sup>2</sup>AS<sup>2</sup>AT<sup>2</sup>

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10/1/97

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**FORM PTO-1449 (MODIFIED)**

ATTY. DOCKET NO.  
5026-101 D1

**SERIAL NO.**  
08/324,060

**LIST OF PATENTS AND PUBLICATIONS FOR  
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STATEMENT**

(USE SEVERAL SHEETS IF NECESSARY)

**APPLICANT**  
Capote et al.

**FILING DATE**  
10/17/94

**GROUP**  
Unknown

**REFERENCE DESIGNATION**

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	FILING DATE SUBCLASS IF APPROPRIATE
<i>MK</i>	AA <sup>3</sup> 4,293,451	10/6/81	ROSS	252	512
↑	AB <sup>3</sup> 4,327,124	4/27/82	DESMARAIS, JR.	427	96
	AC <sup>3</sup> 4,352,899	10/5/82	TADA et al.	523	451
	AD <sup>3</sup> 4,353,816	10/12/82	IWASA	252	512
	AE <sup>3</sup> 4,368,281	1/11/83	BRUMMETT et al.	523	458
	AF <sup>3</sup> 4,396,666	8/2/83	ERNSBERGER	428	208
	AG <sup>3</sup> 4,400,214	8/23/83	OGAWA et al.	252	512
	AH <sup>3</sup> 4,415,486	11/15/83	BOONSTRA et al.	252	514
	AI <sup>3</sup> 4,429,657	2/7/84	DESMARAIS, JR.	118	114
↓	AJ <sup>3</sup> 4,457,861	7/3/84	DESMARAIS, JR.	252	514
<i>MK</i>	AK <sup>3</sup> 4,459,166	7/10/84	DIETZ et al.	156	89

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	NO
✓MK	AL <sup>3</sup> 53-133,799	11/21/78	JAPAN				
✓MK	AM <sup>3</sup> 54-24,811	2/24/79	JAPAN				X
✓MK	AN <sup>3</sup> 56-32,605	4/2/81	JAPAN				X
✓MK	AO <sup>3</sup> 57-113,505	7/15/82	JAPAN				
✓MK	AP <sup>3</sup> 57-208,002	12/21/82	JAPAN				X

**OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)**

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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	FILING DATE SUBCLASS IF APPROPRIATE
JK	AA <sup>4</sup> 4,496,475	8/29/85	ABRAMS	252	514
↑	AB <sup>4</sup> 4,533,685	8/6/85	HUDGIN et al.	523	457
AC <sup>4</sup>	4,557,857	12/10/85	SORENSEN	252	503
AD <sup>4</sup>	4,564,563	1/14/86	MARTIN et al.	252	511
AE <sup>4</sup>	4,575,432	3/11/86	LIN et al.	428	456
AF <sup>4</sup>	4,578,425	3/25/86	SANTORELLI	525	109
AG <sup>4</sup>	4,581,158	4/8/86	LIN	252	511
AH <sup>4</sup>	4,592,861	6/3/86	BEKELE et al.	252	511
AI <sup>4</sup>	4,639,396	1/27/87	SEMSARZADEH	428	373
↓	AJ <sup>4</sup> 4,652,398	3/24/87	GOSWAMI et al.	252	514
JK	AK <sup>4</sup> 4,673,532	6/16/87	BARAJAS et al.	252	512

## FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
JK	AL <sup>4</sup> 58-42,651	3/12/83	JAPAN	—	—	X
↑	AM <sup>4</sup> 58-61,144	4/12/83	JAPAN	—	—	X
↓	AN <sup>4</sup> 58-104,969	6/22/83	JAPAN	—	—	X
AO <sup>4</sup>	58-127,742	7/29/83	JAPAN	—	—	X
JK	AP <sup>4</sup> 59-49,272	3/21/84	JAPAN	—	—	X

## OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS IF APPROPRIATE	FILING DATE
<i>MK</i>	AA <sup>5</sup>	4,678,602	7/7/87	TANAKA et al.	252	513	
	AB <sup>5</sup>	4,680,141	7/14/87	BARAJAS	252	512	
	AC <sup>5</sup>	4,683,653	8/4/87	IWASA	29	830	
	AD <sup>5</sup>	4,696,764	9/29/87	YAMAZAKI	252	503	
	AE <sup>5</sup>	4,705,647	11/10/87	YAMAGUCHI et al.	252	512	
	AF <sup>5</sup>	4,731,130	3/15/88	O'LEARY	148	24	
	AG <sup>5</sup>	4,732,702	3/22/88	YAMAZAKI et al.	252	512	
	AH <sup>5</sup>	4,733,018	3/22/88	PRABHU et al.	174	68.5	
	AI <sup>5</sup>	4,740,252	4/26/88	HASAGAWA et al.	148	24	
	AJ <sup>5</sup>	4,756,756	7/12/88	CASSAT	106	20	
<i>MK</i>	AK <sup>5</sup>	4,765,929	8/23/88	SHAFFER	252	511	

## FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES      NO
<i>MK</i>	AL <sup>5</sup>	59-100,176	6/9/84	JAPAN	—	—	X
	AM <sup>5</sup>	59-166,542	9/19/84	JAPAN	—	—	X
	AN <sup>5</sup>	60-149,670	8/7/85	JAPAN	—	—	X
	AO <sup>5</sup>	60-243,171	12/3/85	JAPAN	—	—	X
<i>MK</i>	AP <sup>5</sup>	60-245,742	12/5/85	JAPAN	—	—	X

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<i>MK</i>	AA <sup>6</sup>	4,775,500	10/4/88	FUNAKOSHI et al.	264	22	
	AB <sup>6</sup>	4,780,371	10/25/88	JOSEPH et al.	523	457	
	AC <sup>6</sup>	4,786,437	11/22/88	EHRREICH	252	506	
	AD <sup>6</sup>	4,789,411	12/6/88	EGUCHI et al.	148	24	
	AE <sup>6</sup>	4,803,543	2/7/89	INAYOSHI et al.	357	72	
	AF <sup>6</sup>	4,808,434	2/28/89	BENNETT et al.	427	96	
	AG <sup>6</sup>	4,816,184	3/28/89	FUKUDA et al.	252	511	
	AH <sup>6</sup>	4,820,446	4/11/89	PRUD'HOMME	252	511	
	AI <sup>6</sup>	4,830,779	5/16/89	MAENO et al.	252	512	
	AJ <sup>6</sup>	4,836,955	6/6/89	EHRREICH	252	512	
<i>MK</i>	AK <sup>6</sup>	4,859,268	8/22/89	JOSEPH et al.	156	275,5	

## FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES      NO
<i>MK</i> AL <sup>6</sup> 61-57,660	3/24/86	JAPAN	—	—	X
AM <sup>6</sup> 61-261,375	11/19/86	JAPAN	—	—	X
AN <sup>6</sup> 61-287,974	12/18/86	JAPAN	—	—	X
AO <sup>6</sup> 62-156,176	7/11/87	JAPAN	—	—	X
<i>MK</i> AP <sup>6</sup> 62-160,603	7/16/87	JAPAN	—	—	X

## OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

AR<sup>6</sup>AS<sup>6</sup>AT<sup>6</sup>

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<i>MK</i>	AA <sup>7</sup>	4,872,928	10/10/89	JACOBS	148	24	
	AB <sup>7</sup>	4,874,548	10/17/89	HAJOVSKY	252	511	
	AC <sup>7</sup>	4,880,570	11/14/89	SANBORN et al.	252	512	
	AD <sup>7</sup>	4,882,227	11/21/89	IWASE et al.	428	407	
	AE <sup>7</sup>	4,888,135	12/19/89	TSUNAGA et al.	252	512	
	AF <sup>7</sup>	4,894,184	1/16/90	FUKUOKA et al.	252	512	
	AG <sup>7</sup>	4,940,498	7/10/90	RUBIN	148	23	
	AH <sup>7</sup>	4,971,727	11/20/90	TAKAHASHI et al.	252	511	
	AI <sup>7</sup>	4,996,005	2/26/91	SAITO et al.	252	512	
<i>MK</i>	AJ <sup>7</sup>	3,502,609	3/24/70	BARIE et al.	260	37	
	AK <sup>7</sup>						

## FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES      NO
<i>MK</i>	AL <sup>7</sup>	63-39,947	2/20/88	JAPAN	—	—	X
	AM <sup>7</sup>	63-81,185	4/12/88	JAPAN	—	—	X
	AN <sup>7</sup>	63-125,582	5/28/88	JAPAN	—	—	X
	AO <sup>7</sup>	63-223,072	9/16/88	JAPAN	—	—	X
<i>MK</i>	AP <sup>7</sup>	63-235,369	9/30/88	JAPAN	—	—	X

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	AA <sup>8</sup>					
	AB <sup>8</sup>					
	AC <sup>8</sup>					
	AD <sup>8</sup>					
	AE <sup>8</sup>					
	AF <sup>8</sup>					
	AG <sup>8</sup>					
	AH <sup>8</sup>					
	AI <sup>8</sup>					
	AJ <sup>8</sup>					
	AK <sup>8</sup>					

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	NO
JK	AL <sup>8</sup> 63-277,279	11/15/88	JAPAN	—	—		X
JK	AM <sup>8</sup> 63-298,908	12/6/88	JAPAN	—	—		X
JK	AN <sup>8</sup> 63-301,405	12/8/88	JAPAN	—	—		X
JK	AO <sup>8</sup> 64-81,866	3/28/89	JAPAN	—	—		X
JK	AP <sup>8</sup> 1-204,966	8/17/89	JAPAN	—	—		X

## OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

AR<sup>8</sup>AS<sup>8</sup>AT<sup>8</sup>EXAMINER *Mark K*

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	AA <sup>9</sup>				
	AB <sup>9</sup>				
	AC <sup>9</sup>				
	AD <sup>9</sup>				
	AE <sup>9</sup>				
	AF <sup>9</sup>				
	AG <sup>9</sup>				
	AH <sup>9</sup>				
	AI <sup>9</sup>				
	AJ <sup>9</sup>				
	AK <sup>9</sup>				

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	NO
mk	AL <sup>9</sup> 1-132,652	5/25/89	JAPAN	—	—		X
mk	AM <sup>9</sup> 2-66,802	3/6/90	JAPAN	—	—		X
mk	AN <sup>9</sup> 2-66,803	3/6/90	JAPAN	—	—		X
mk	AO <sup>9</sup> 55-160,072	12/12/80	JAPAN	—	—		X
mk	AP <sup>9</sup> WO 89/11209	11/16/89	PCT	—	—		

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